

74AC377 • 74ACT377

Octal D-Type Flip-Flop with Clock Enable

General Description

The AC/ACT377 has eight edge-triggered, D-type flip-flops with individual D inputs and Q outputs. The common buffered Clock (CP) input loads all flip-flops simultaneously, when the Clock Enable (\overline{CE}) is LOW.

The register is fully edge-triggered. The state of each D input, one setup time before the LOW-to-HIGH clock transition, is transferred to the corresponding flip-flop's Q output. The \overline{CE} input must be stable only one setup time prior to the LOW-to-HIGH clock transition for predictable operation.

Features

- I_{CC} reduced by 50%
- Ideal for addressable register applications
- Clock enable for address and data synchronization applications
- Eight edge-triggered D-type flip-flops
- Buffered common clock
- Outputs source/sink 24 mA
- See 273 for master reset version
- See 373 for transparent latch version
- See 374 for 3-STATE version
- ACT377 has TTL-compatible inputs

Ordering Code:

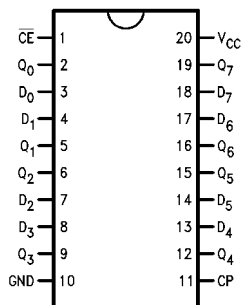
| Order Number | Package Number | Package Description |
|-------------------------|----------------|---|
| 74AC377SC | M20B | 20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide |
| 74AC377SJ | M20D | Pb-Free 20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74AC377MTC | MTC20 | 20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74AC377MTCX_NL (Note 1) | MTC20 | Pb-Free 20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74AC377PC | N20A | 20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide |
| 74ACT377SC | M20B | 20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide |
| 74ACT377SJ | M20D | Pb-Free 20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74ACT377MTC | MTC20 | 20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74ACT377PC | N20A | 20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide |

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Pb-Free package per JEDEC J-STD-020B.

Note 1: "_NL" indicates Pb-Free package (per JEDEC J-STD-020B). Device available in Tape and Reel only.

Connection Diagram

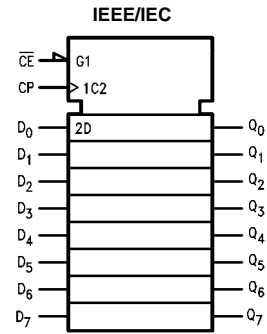
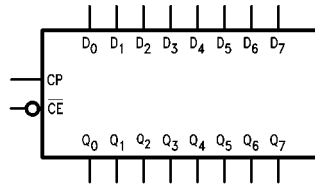


Pin Descriptions

| Pin Names | Description |
|-----------------|---------------------------|
| D_0 – D_7 | Data Inputs |
| \overline{CE} | Clock Enable (Active LOW) |
| Q_0 – Q_7 | Data Outputs |
| CP | Clock Pulse Input |

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Logic Symbols

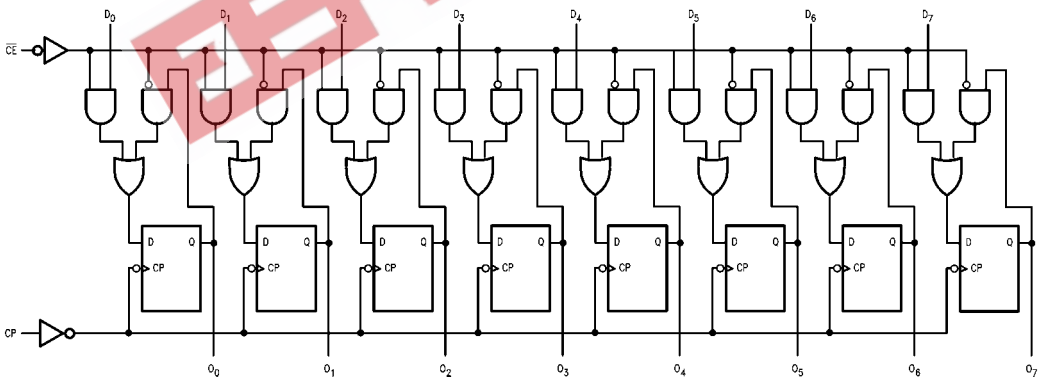


Mode Select-Function Table

| Operating Mode | Inputs | | | Outputs |
|-------------------|--------|-----------------|-------|-----------|
| | CP | \overline{CE} | D_n | Q_n |
| Load '1' | ↗ | L | H | H |
| Load '0' | ↗ | L | L | L |
| Hold (Do Nothing) | ↗ | H | X | No Change |
| | X | H | X | No Change |

H = HIGH Voltage Level
 L = LOW Voltage Level
 X = Immaterial
 ↗ = LOW-to-HIGH Clock Transition

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 2)

| | |
|--|--------------------------|
| Supply Voltage (V_{CC}) | -0.5V to +7.0V |
| DC Input Diode Current (I_{IK}) | |
| $V_I = -0.5V$ | -20 mA |
| $V_I = V_{CC} + 0.5V$ | +20 mA |
| DC Input Voltage (V_I) | -0.5V to $V_{CC} + 0.5V$ |
| DC Output Diode Current (I_{OK}) | |
| $V_O = -0.5V$ | -20 mA |
| $V_O = V_{CC} + 0.5V$ | +20 mA |
| DC Output Voltage (V_O) | -0.5V to $V_{CC} + 0.5V$ |
| DC Output Source | |
| or Sink Current (I_O) | ± 50 mA |
| DC V_{CC} or Ground Current | |
| per Output Pin (I_{CC} or I_{GND}) | ± 50 mA |
| Storage Temperature (T_{STG}) | -65°C to +150°C |
| Junction Temperature (T_J) | |
| PDIP | 140°C |

Recommended Operating Conditions

| | |
|---|----------------|
| Supply Voltage (V_{CC}) | |
| AC | 2.0V to 6.0V |
| ACT | 4.5V to 5.5V |
| Input Voltage (V_I) | 0V to V_{CC} |
| Output Voltage (V_O) | 0V to V_{CC} |
| Operating Temperature (T_A) | -40°C to +85°C |
| Minimum Input Edge Rate ($\Delta V/\Delta t$) | |
| AC Devices | |
| V_{IN} from 30% to 70% of V_{CC} | |
| V_{CC} @ 3.3V, 4.5V, 5.5V | 125 mV/ns |
| Minimum Input Edge Rate ($\Delta V/\Delta t$) | |
| ACT Devices | |
| V_{IN} from 0.8V to 2.0V | |
| V_{CC} @ 4.5V, 5.5V | 125 mV/ns |

Note 2: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics for AC

| Symbol | Parameter | V_{CC} (V) | $T_A = -25^\circ\text{C}$ | | $T_A = -40^\circ\text{C to } +85^\circ\text{C}$ | | Units | Conditions |
|----------------------|--------------------------------------|-------------------------------------|---------------------------|-------------------|---|-------------------|--|---|
| | | | Typ | Guaranteed Limits | Guaranteed Limits | Guaranteed Limits | | |
| V_{IH} | Minimum HIGH Level Input Voltage | 3.0 | 1.5 | 2.1 | 2.1 | V | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$ | |
| | | 4.5 | 2.25 | 3.15 | 3.15 | | | |
| | | 5.5 | 2.75 | 3.85 | 3.85 | | | |
| V_{IL} | Maximum LOW Level Input Voltage | 3.0 | 1.5 | 0.9 | 0.9 | V | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$ | |
| | | 4.5 | 2.25 | 1.35 | 1.35 | | | |
| | | 5.5 | 2.75 | 1.65 | 1.65 | | | |
| V_{OH} | Minimum HIGH Level Output Voltage | 3.0 | 2.99 | 2.9 | 2.9 | V | $I_{OUT} = -50 \mu A$ | |
| | | 4.5 | 4.49 | 4.4 | 4.4 | | | |
| | | 5.5 | 5.49 | 5.4 | 5.4 | | | |
| | V_{OL} | Maximum LOW Level Output Voltage | 3.0 | | 2.56 | 2.46 | V | $V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -12$ mA $I_{OH} = -24$ mA $I_{OH} = -24$ mA (Note 3) |
| | | | 4.5 | | 3.86 | 3.76 | | |
| | | | 5.5 | | 4.86 | 4.76 | | |
| V_{OL} | Maximum LOW Level Output Voltage | 3.0 | 0.002 | 0.1 | 0.1 | V | $I_{OUT} = 50 \mu A$ | |
| | | 4.5 | 0.001 | 0.1 | 0.1 | | | |
| | | 5.5 | 0.001 | 0.1 | 0.1 | | | |
| | I_{IN} (Note 5) | Maximum Input Leakage Current | 3.0 | | 0.36 | 0.44 | μA | $V_I = V_{CC}$, GND |
| | | | 4.5 | | 0.36 | 0.44 | | |
| | | | 5.5 | | 0.36 | 0.44 | | |
| I_{OLD} | Minimum Dynamic | 5.5 | | | 75 | mA | $V_{OLD} = 1.65V$ Max | |
| I_{OHD} | Output Current (Note 4) | 5.5 | | | -75 | mA | $V_{OHD} = 3.85V$ Min | |
| I_{CC} (Note 5) | Maximum Quiescent Supply Current | 5.5 | | 4.0 | 40.0 | μA | $V_{IN} = V_{CC}$ or GND | |

Note 3: All outputs loaded; thresholds on input associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

DC Electrical Characteristics for ACT

| Symbol | Parameter | V _{CC} (V) | T _A = +25°C | | T _A = -40°C to +85°C | | Units | Conditions |
|------------------|--------------------------------------|------------------------|------------------------|-------------------|---------------------------------|----|---|------------|
| | | | Typ | Guaranteed Limits | | | | |
| V _{IH} | Minimum HIGH Level Input Voltage | 4.5 | 1.5 | 2.0 | 2.0 | V | V _{OUT} = 0.1V or V _{CC} - 0.1V | |
| | | 5.5 | 1.5 | 2.0 | 2.0 | | | |
| V _{IL} | Maximum LOW Level Input Voltage | 4.5 | 1.5 | 0.8 | 0.8 | V | V _{OUT} = 0.1V or V _{CC} - 0.1V | |
| | | 5.5 | 1.5 | 0.8 | 0.8 | | | |
| V _{OH} | Minimum HIGH Level Output Voltage | 4.5 | 4.49 | 4.4 | 4.4 | V | I _{OUT} = -50 μA | |
| | | 5.5 | 5.49 | 5.4 | 5.4 | | | |
| | | 4.5 | | 3.86 | 3.76 | V | V _{IN} = V _{IL} or V _{IH} I _{OH} = -24 mA I _{OH} = -24 mA (Note 6) | |
| | | 5.5 | | 4.86 | 4.76 | | | |
| V _{OL} | Maximum LOW Level Output Voltage | 4.5 | 0.001 | 0.1 | 0.1 | V | I _{OUT} = 50 μA | |
| | | 5.5 | 0.001 | 0.1 | 0.1 | | | |
| | | 4.5 | | 0.36 | 0.44 | V | V _{IN} = V _{IL} or V _{IH} I _{OL} = 24 mA I _{OL} = 24 mA (Note 6) | |
| | | 5.5 | | 0.36 | 0.44 | | | |
| I _{IN} | Maximum Input Leakage Current | 5.5 | | ±0.1 | ±1.0 | μA | V _I = V _{CC} , GND | |
| I _{CC} | Maximum I _{CC} /Input | 5.5 | 0.6 | | 1.5 | mA | V _I = V _{CC} - 2.1V | |
| I _{OLD} | Minimum Dynamic | 5.5 | | | 75 | mA | V _{OLD} = 1.65V Max | |
| I _{OHD} | Output Current (Note 7) | 5.5 | | | -75 | mA | V _{OHD} = 3.85V Min | |
| I _{CC} | Maximum Quiescent Supply Current | 5.5 | | 4.0 | 40.0 | μA | V _{IN} = V _{CC} or GND | |

Note 6: All outputs loaded; thresholds on input associated with output under test.

Note 7: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics for AC

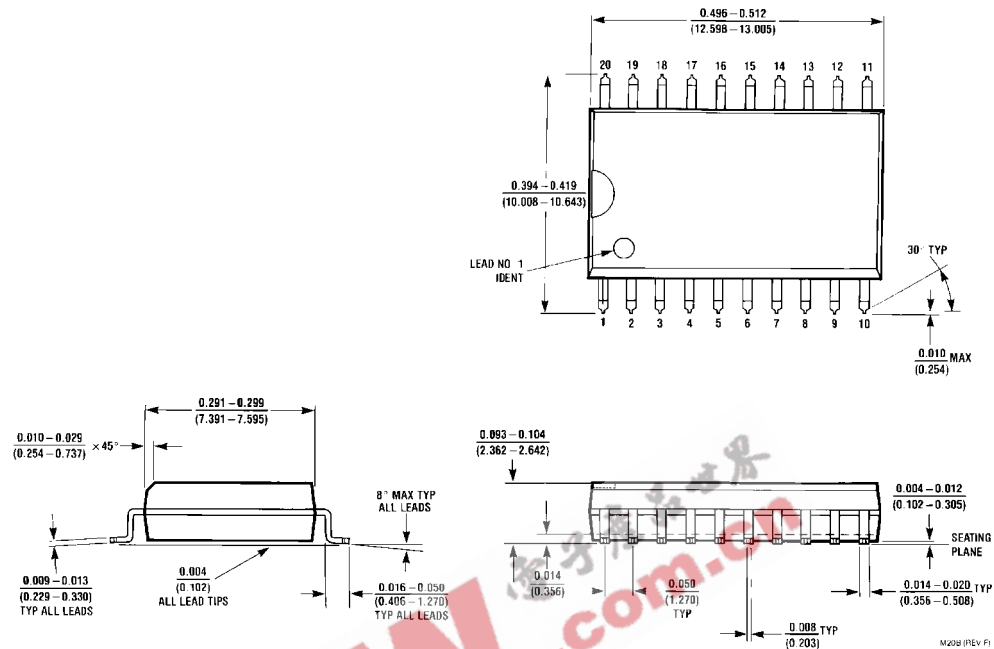
| Symbol | Parameter | V _{CC} (V) (Note 8) | T _A = +25°C | | | T _A = -40°C to +85°C | | Units |
|------------------|---|------------------------------------|------------------------|-----|------|---------------------------------|------|-------|
| | | | Min | Typ | Max | Min | Max | |
| f _{MAX} | Maximum Clock Frequency | 3.3 | 90 | 125 | | 75 | MHz | |
| | | 5.0 | 140 | 175 | | 125 | | |
| t _{PLH} | Propagation Delay CP to Q _n | 3.3 | 3.0 | 8.0 | 13.0 | 1.5 | 14.0 | ns |
| | | 5.0 | 2.0 | 6.0 | 9.0 | 1.5 | 10.0 | |
| t _{PHL} | Propagation Delay CP to Q _n | 3.3 | 3.5 | 8.5 | 13.0 | 2.0 | 14.5 | ns |
| | | 5.0 | 2.5 | 6.5 | 10.0 | 1.5 | 11.0 | |

Note 8: Voltage Range 3.3 is 3.3V ± 0.3V

Voltage Range 5.0 is 5.0V ± 0.5V

| AC Operating Requirements for AC | | | | | | | | |
|---|--|-------------------------------------|--|------------------------|---|---|-------|-------|
| Symbol | Parameter | V _{CC} (V) (Note 9) | T _A = +25°C C _L = 50 pF | | T _A = -40°C to +85°C C _L = 50 pF | | Units | |
| | | | Typ | Guaranteed Minimum | | | | |
| t _S | Setup Time, HIGH or LOW D _n to CP | 3.3 | 3.5 | 5.5 | 6.0 | | ns | |
| | | 5.0 | 2.5 | 4.0 | 4.5 | | | |
| t _H | Hold Time, HIGH or LOW D _n to CP | 3.3 | -2.0 | 0 | 0 | | ns | |
| | | 5.0 | -1.0 | 1.0 | 1.0 | | | |
| t _S | Setup Time, HIGH or LOW \overline{CE} to CP | 3.3 | 4.0 | 6.0 | 7.5 | | ns | |
| | | 5.0 | 2.5 | 4.0 | 4.5 | | | |
| t _H | Hold Time, HIGH or LOW \overline{CE} to CP | 3.3 | -3.5 | 0 | 0 | | ns | |
| | | 5.0 | -2.0 | 1.0 | 1.0 | | | |
| t _W | CP Pulse Width HIGH or LOW | 3.3 | 3.5 | 5.5 | 6.0 | | ns | |
| | | 5.0 | 2.5 | 4.0 | 4.5 | | | |
| Note 9: Voltage Range 3.3 is 3.0V ± 0.3V Voltage Range 5.0 is 5.0V ± 0.5V | | | | | | | | |
| AC Electrical Characteristics for ACT | | | | | | | | |
| Symbol | Parameter | V _{CC} (V) (Note 10) | T _A = +25°C C _L = 50 pF | | | T _A = -40°C to +85°C C _L = 50 pF | | Units |
| | | | Min | Typ | Max | Min | Max | |
| f _{MAX} | Maximum Clock Frequency | 5.0 | 140 | 175 | 125 | | MHz | |
| t _{PLH} | Propagation Delay CP to Q _n | 5.0 | 3.0 | 6.5 | 9.0 | 2.5 | 10.0 | ns |
| t _{PHL} | Propagation Delay CP to Q _n | 5.0 | 3.5 | 7.0 | 10.0 | 2.5 | 11.0 | ns |
| Note 10: Voltage Range 5.0 is 5.0V ± 0.5V | | | | | | | | |
| AC Operating Requirements for ACT | | | | | | | | |
| Symbol | Parameter | V _{CC} (V) (Note 11) | T _A = +25°C C _L = 50 pF | | T _A = -40°C to +85°C C _L = 50 pF | | Units | |
| | | | Typ | Guaranteed Minimum | | | | |
| t _S | Setup Time, HIGH or LOW D _n to CP | 5.0 | 2.5 | 4.5 | 5.5 | | ns | |
| | | | | | | | | |
| t _H | Hold Time, HIGH or LOW D _n to CP | 5.0 | -1.0 | 1.0 | 1.0 | | ns | |
| | | | | | | | | |
| t _S | Setup Time, HIGH or LOW \overline{CE} to CP | 5.0 | 2.5 | 4.5 | 5.5 | | ns | |
| | | | | | | | | |
| t _H | Hold Time, HIGH or LOW \overline{CE} to CP | 5.0 | -1.0 | 1.0 | 1.0 | | ns | |
| | | | | | | | | |
| t _W | CP Pulse Width HIGH or LOW | 5.0 | 2.0 | 4.0 | 4.5 | | ns | |
| | | | | | | | | |
| Note 11: Voltage Range 5.0 is 5.0V ± 0.5V | | | | | | | | |
| Capacitance | | | | | | | | |
| Symbol | Parameter | Typ | Units | Conditions | | | | |
| C _{IN} | Input Capacitance | 4.5 | pF | V _{CC} = OPEN | | | | |
| C _{PD} | Power Dissipation Capacitance | 90.0 | pF | V _{CC} = 5.0V | | | | |

Physical Dimensions inches (millimeters) unless otherwise noted

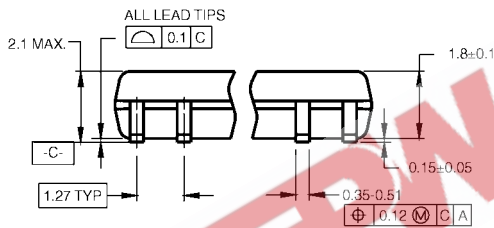


**20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
Package Number M20B**

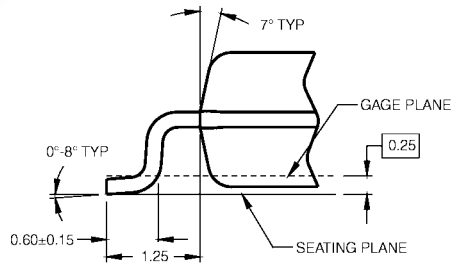
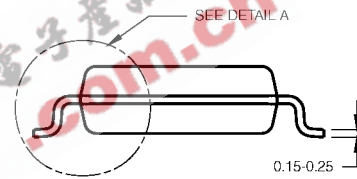
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



LAND PATTERN RECOMMENDATION



DIMENSIONS ARE IN MILLIMETERS



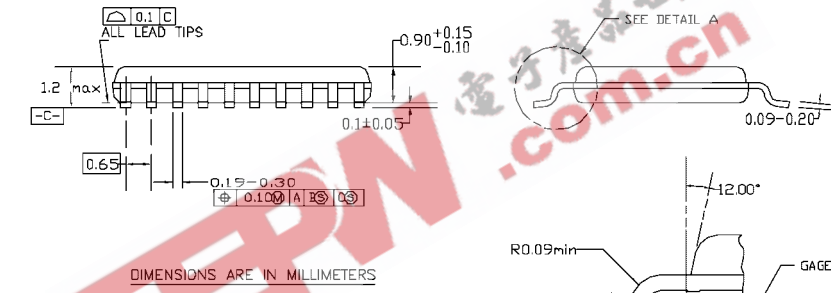
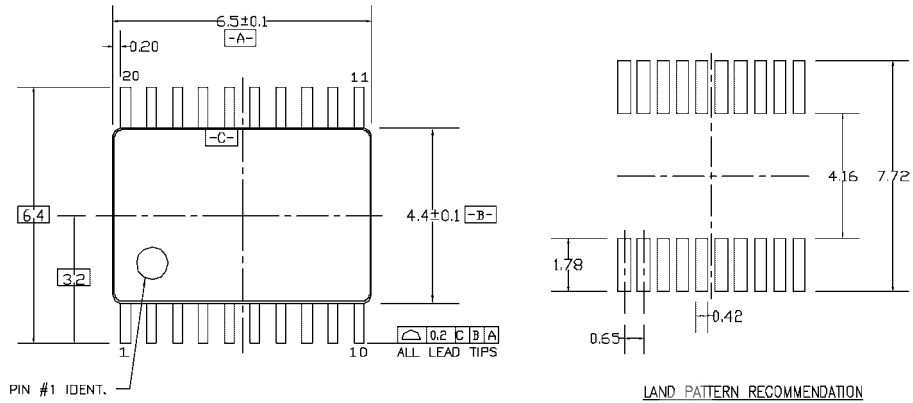
DETAIL A

- NOTES:
- A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.
 - B. DIMENSIONS ARE IN MILLIMETERS.
 - C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

M20DRevB1

**Pb-Free 20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
Package Number M20D**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



DIMENSIONS ARE IN MILLIMETERS

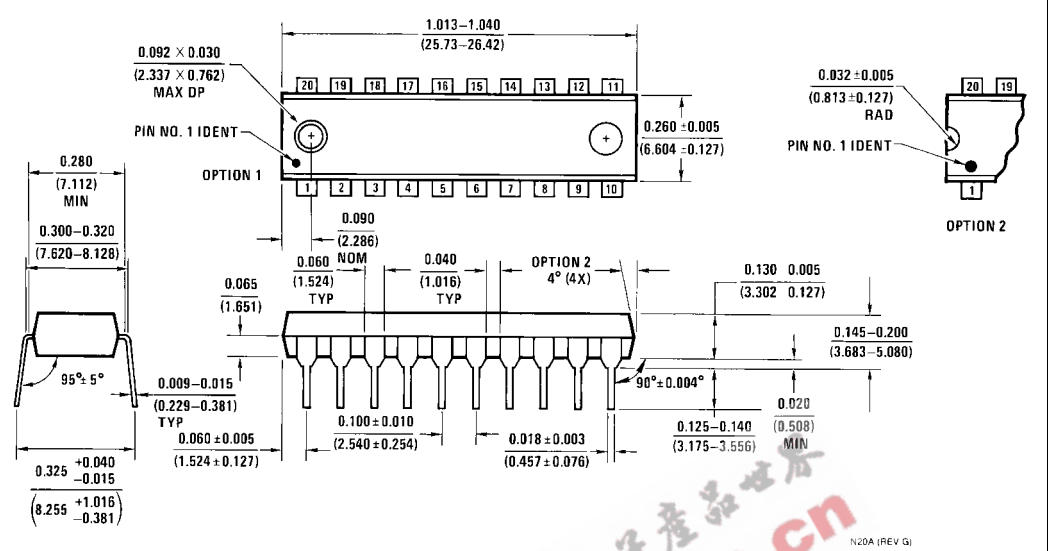
NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AC, REF NOTE 8, DATE 7/93.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLDS FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTC20REV D1

20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC20

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N20A

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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